

FRED Ultrafast Soft Recovery Diode, 30 A

FEATURES

- Ultrafast recovery
- 175°C operating junction temperature
- Designed and qualified for industrial level
- Compliant to RoHS

BENEFITS

- Reduced RFI and EMI
- Higher frequency operation
- Reduced snubbing
- Reduced parts count

DESCRIPTION/APPLICATIONS

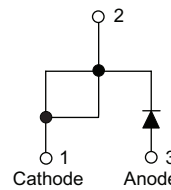
These diodes are optimized to reduce losses and EMI/RFI in high frequency power conditioning systems.

The softness of the recovery eliminates the need for a snubber in most applications. These devices are ideally suited for HF welding, power converters and other applications where switching losses are not significant portion of the total losses.

N-30EPU12

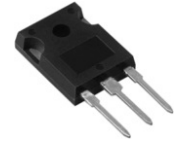


Cathode to base

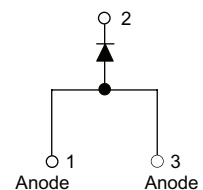


TO-247AC modified

N-30APU12



Cathode to base



TO-247AB

PRODUCT SUMMARY

t_{rr}	26 ns
$I_{F(AV)}$	30 A
V_R	1200 V

ABSOLUTE MAXIMUM RATINGS

PARAMETER	SYMBOL	TEST CONDITIONS	VALUES	UNITS
Cathode to anode voltage	V_R		1200	V
Continuous forward current	$I_{F(AV)}$	$T_C = 100\text{ }^\circ\text{C}$	30	A
Single pulse forward current	I_{FSM}	$T_C = 25\text{ }^\circ\text{C}$	280	
Operating junction and storage temperatures	T_j, T_{Stg}		- 55 to 175	$^\circ\text{C}$

ELECTRICAL SPECIFICATIONS ($T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified)

PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Breakdown voltage, blocking voltage	V_{BR}, V_f	$I_R = 100\mu\text{A}$	1200	-	-	V
Forward voltage	V_F	$I_F = 30\text{A}$	-	2.7	3.3	
		$I_F = 60\text{A}$	-	3.4	-	
Reverse leakage current	I_R	$V_R = V_R$ rated	-	-	100	μA
		$T_J = 150\text{ }^\circ\text{C}, V_R = V_R$ rated	-	-	500	
Junction capacitance	C_T	$V_R = 200\text{V}$	-	36	-	pF

DYNAMIC RECOVERY CHARACTERISTICS (T _J = 25 °C unless otherwise specified)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Reverse recovery time	t _{rr}	I _F = 0.5A, I _R = 1A, I _{RR} = 0.25A (RG#1 CKT)	-	55	60	ns
		I _F = 1A, dI _F /dt = -100 A/μs, V _R = 30V, T _J = 25°C	-	26	-	
		T _J = 25°C	-	320	-	
		T _J = 125°C	-	435	-	
Peak recovery current	I _{RRM}	T _J = 25°C	-	4	-	A
		T _J = 125°C	-	9	-	
Reverse recovery charge	Q _{rr}	T _J = 25°C	-	545	-	nC
		T _J = 125°C	-	2100	-	

THERMAL - MECHANICAL SPECIFICATIONS						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNITS
Thermal resistance, junction to case	R _{thJC}		-	0.5	0.8	°C/W
Thermal resistance, case to heatsink	R _{thCS}	Mounting surface, flat, smooth and greased	-	0.4	-	
Weight			-	5.5	-	g
			-	0.2	-	oz.
Mounting torque			0.6 (5)	-	1.2 (10)	N · m (lbf · in)
Marking device		Case style TO-247AC modified	30EPU12			
		Case style TO-247AB	30APU12			

Fig.1 Maximum effective transient thermal impedance, junction-to-case vs. pulse duration

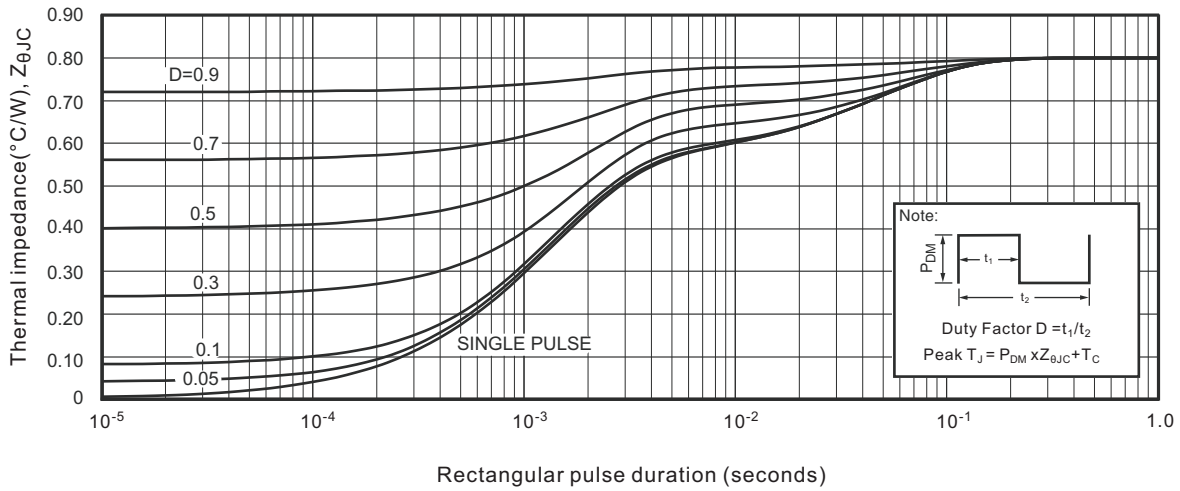


Fig.2 Forward current vs. forward voltage

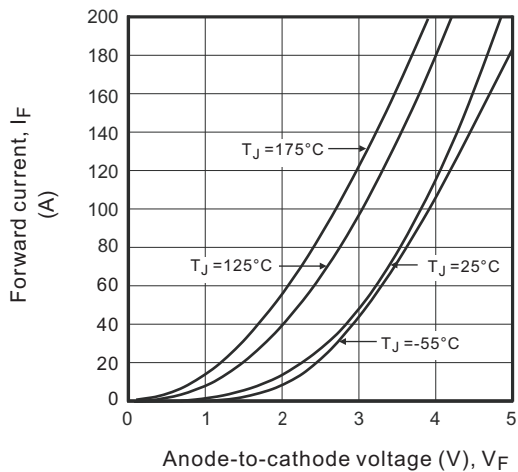


Fig.3 Reverse recovery time vs. current rate of change

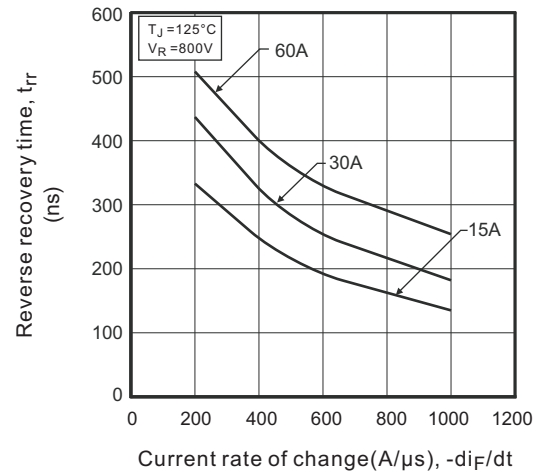


Fig.4 Reverse recovery charge vs. current rate of change

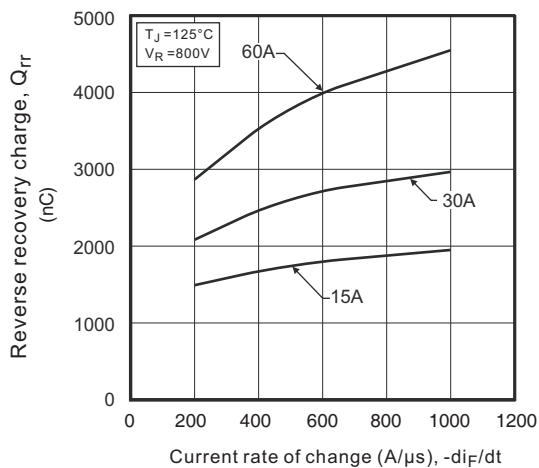
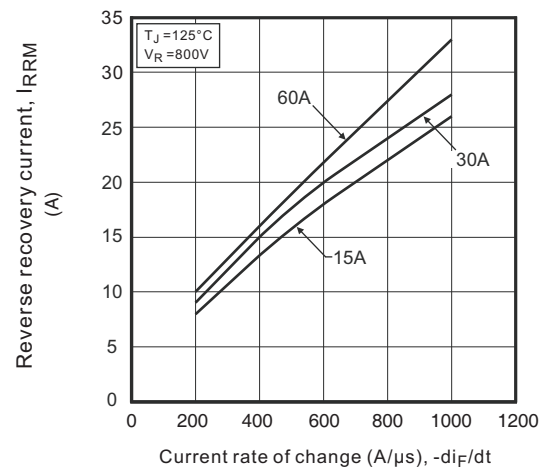


Fig 5. Reverse recovery current vs. current rate of change



Nell High Power Products

Fig.6. Dynamic parameters vs. junction temperature

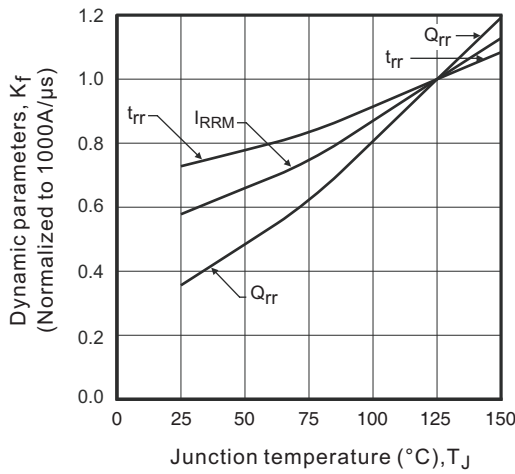


Fig.7 Maximum average forward current vs. case temperature

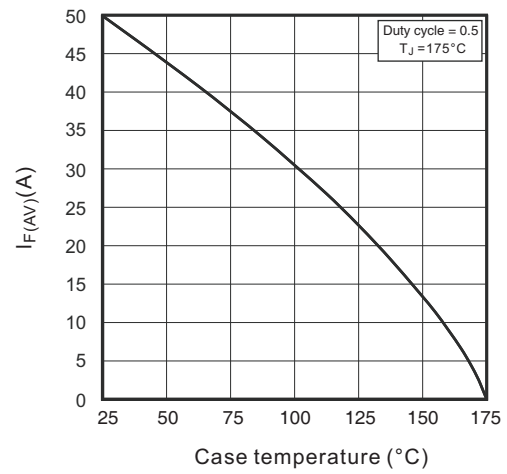
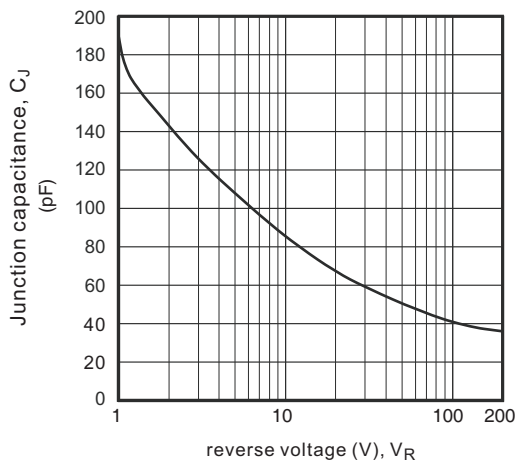
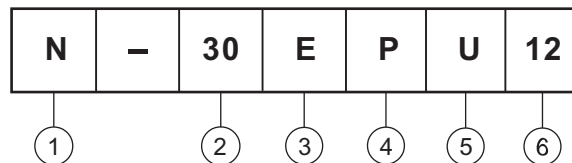


Fig.8 Junction capacitance vs. reverse voltage



Ordering Information Tabel

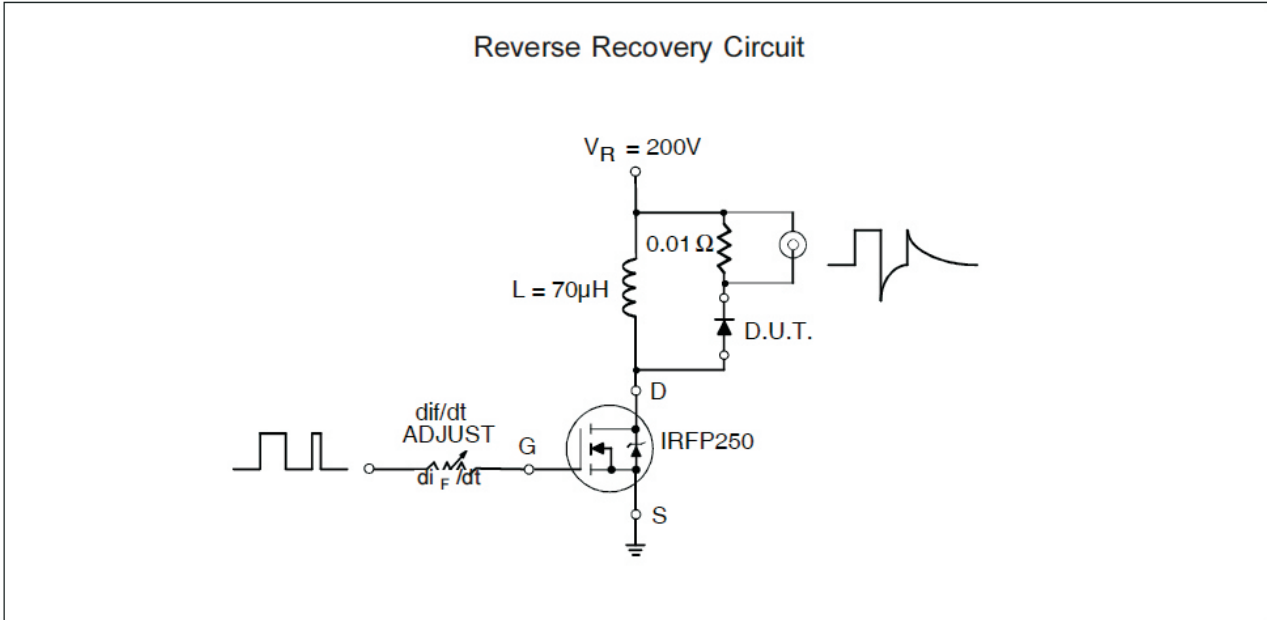
Device code



- 1 - Nell
- 2 - Current rating (30 = 30A)
- 3 - Single Diode
- 4 - TO-247
- 5 - Ultrafast Recovery
- 6 - Voltage Rating (12 = 1200 V)

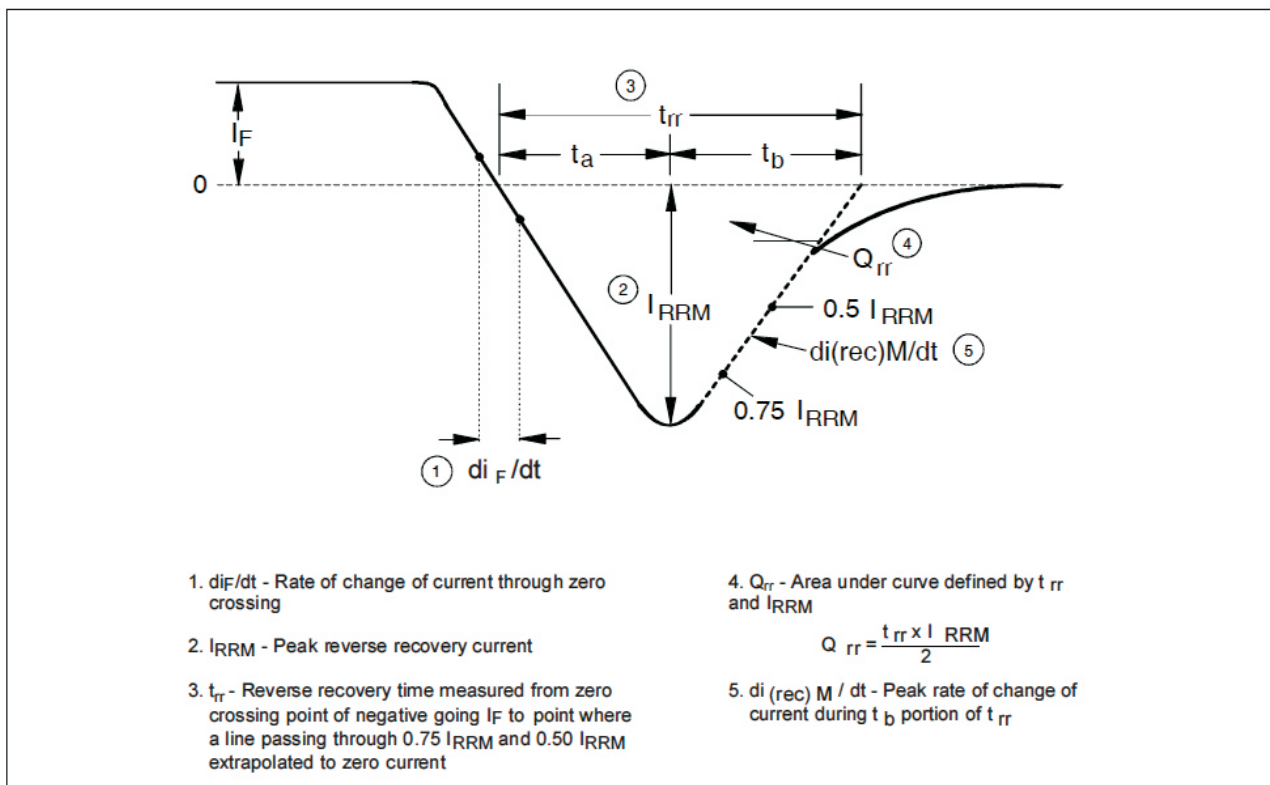
E = 2 pins
A = 3 pins

Fig.9 Reverse recovery parameter test circuit

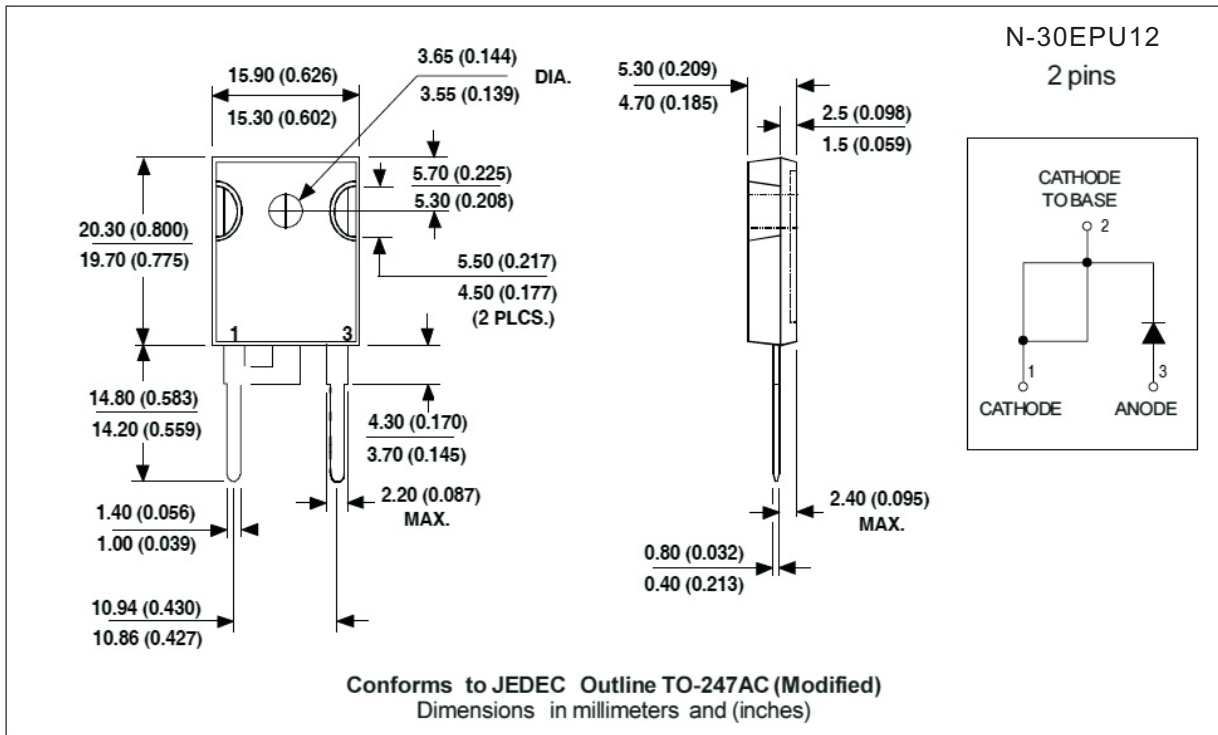


- (3) Formula used: $T_C = T_J - (P_d + P_{d_{REV}}) \times R_{thJC}$;
 $P_d = \text{Forward Power Loss} = I_{F(AV)} \times V_{FM} @ (I_{F(AV)} / D)$ (see Fig. 6);
 $P_{d_{REV}} = \text{Inverse Power Loss} = V_{R1} \times I_R (1 - D)$; $I_R @ V_{R1} = 80\% \text{ rated } V_R$

Fig.10 Reverse recovery waveform and definitions



Outline Table



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